

Preliminary

SIPC06N60C2

Fast CoolMOSTM Power Transistor

FEATURES:

Applications:

- New revolutionary high voltage technology
- Ultra low gate charge
- Worlbest R_{DS(on)} per chip area Ultra low effective capacitances
- Improved noise immunity



Chip Type	V _{DS}	I _D	Die Size	Package	Ordering Code
SIPC06N60C2	600V	4A	2.45 x 2.60 mm ²	sawn on foil	tbd

MECHANICAL PARAMETER:

Raster size	2.45 x 2.60	
Source pad size	1.64 x 2.02	
Gate pad size	0.47 x 0.53	
Area total / active	6.37 / 3.96	
Thickness	175	μm
Wafer size	150	mm
Flat position	0	grd
Max.possible chips per wafer	2388	
Passivation frontside	Photoimide	
Emitter metallization	3200 nm Al Si 1%	
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding	
Die bond	electrically conductive glue or solder	
Wire bond (proposed)	Source: AI, ≤ 500µm; Gate: AI, ≤ 125µm	
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm	
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month	



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Drain-Source voltage	V _{DS}	600	V
DC drain current, limited by T _{jmax}	I _D	4	А
Pulsed drain current, t _p limited by T _{jmax}	I _{Dpuls}	8	Α
Gate source voltage	V _{GS}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C
Reverse diode dv/dt I_S =4A, V_{DSS} , di/dt=100 A/ μ s, T_{jmax} =150°C	dv/dt	6	KV/μs

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
· urumoto.		Conditions	min.	typ.	max.	
Drain-source breakdown voltage	V _{(BR)DSS}	V_{GS} =0V , I_D = 0.25mA			600	V
Gate-source on-state resistance	R _{DS(on)}	V _{GS} =10V, I _D =2.8A		0.95	1.2 ¹⁾	Ω
Gate threshold voltage	V _{GS(th)}	$I_D=191\mu A$, $V_{GS}=V_{DS}$	3.5	4.5	5.5	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =600V , V _{GS} =0V		0.1	25	μΑ
Gate-source leakage current	I _{GSS}	V _{DS} =0V , V _{GS} =25V			100	nA

¹⁾ this correlates to a max. $R_{DS(on)}$ -value of 0.95 Ω at V_{GS} =10V, I_D =2.8A of this chip packaged in a TO220-package

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			- Unit
raiametei	Symbol	Conditions	min.	typ.	max.	Ollic
Input capacitance	Ciss	$V_{DS}=25V$,	-	580	-	pF
Output capacitance	Coss	$V_{GS}=0V$,	-	220	-	
Reverse transfer capacitance	Crss	f=1MHz	-	7	-	

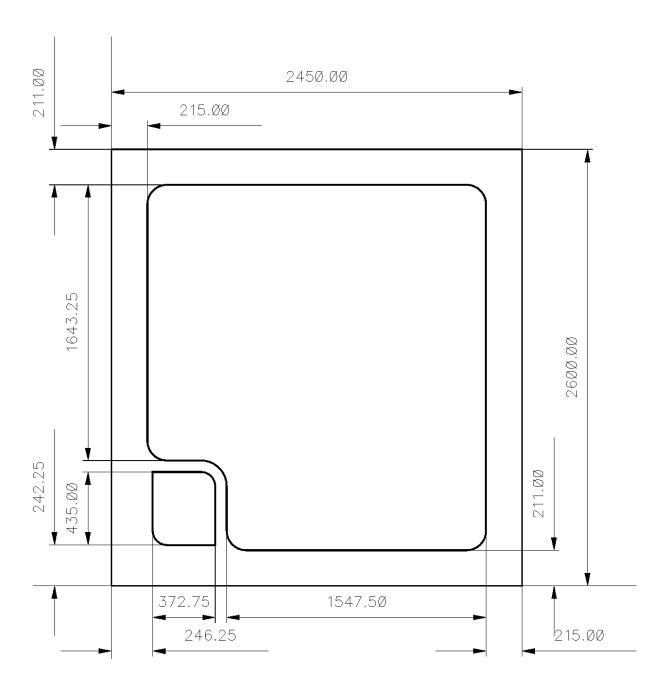
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol Condition	Conditions	Value			Unit
raiametei		Conditions	min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =25 ° C	ı	55	-	ns
Rise time	t_{r}	$V_{DD} = 350 \text{V},$ $I_{D} = 4.5 \text{ A},$ $V_{GS} = 10 \text{V},$	-	30	-	
Turn-off delay time	$t_{d(off)}$		-	60	-	
Fall time	t _f	$R_{\rm G}$ = 18 Ω	-	15	-	



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CHIP DRAWING:





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FURTHER ELECTRICAL CHARACTERISTICS:					
This chip data sheet refers to the					
device data sheet					
DESCRIPTION:					
AQL 0,65 for visual inspection according to failure catalog					
Electrostatic Discharge Sensitive Device according to MIL-STD 883					
Test-Normen Villach/Prüffeld					

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